

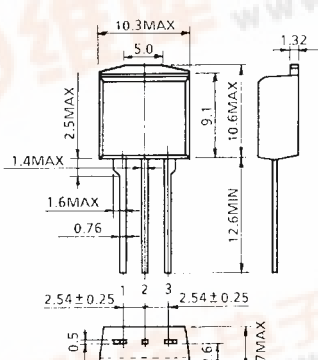
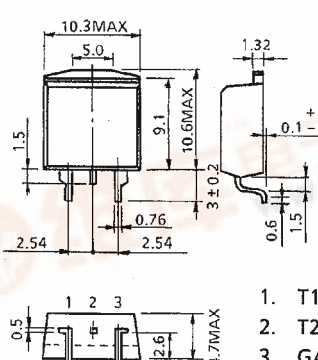
**TOSHIBA****SM8(G,J)48,USM8(G,J)48,SM8(G,J)48A,USM8(G,J)48A**

TOSHIBA BI-DIRECTIONAL TRIODE THYRISTOR SILICON PLANAR TYPE

**SM8G48,USM8G48,SM8J48,USM8J48**  
**SM8G48A,USM8G48A,SM8J48A,USM8J48A****AC POWER CONTROL APPLICATIONS**

- Repetitive Peak Off-State Voltage :  $V_{DRM} = 400, 600V$
- R.M.S On-State Current :  $I_T (RMS) = 8A$
- Gate Trigger Current
  - :  $I_{GT} = 30mA$  Max.
  - :  $I_{GT} = 20mA$  Max. ("A"Type)

Unit: mm

SM8G48, SM8J48, SM8G48A, SM8J48A		USM8G48, USM8J48, USM8G48A, USM8J48A	
			
JEDEC	—	JEDEC	—
JEITA	—	JEITA	—
TOSHIBA	13-10J1A	TOSHIBA	13-10J2A

Weight: 1.7g

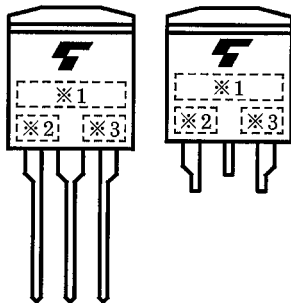
**MAXIMUM RATINGS**


CHARACTERISTIC	SYMBOL	RATING	UNIT
Repetitive Peak Off-State Voltage	(U)SM8G48 (U)SM8G48A	400	V
	(U)SM8J48 (U)SM8J48A	600	
R.M.S On-State Current	$I_T (RMS)$	8	A
Peak One Cycle Surge On-State Current (Non-Repetitive)	$I_{TSM}$	80 (50Hz)	A
		88 (60Hz)	
$I^2t$ Limit Value	$I^2t$	32	$A^2s$
Critical Rate of Rise of On-State Current (Note 1)	$di / dt$	50	$A / \mu s$
Peak Gate Power Dissipation	$P_{GM}$	5	W
Average Gate Power Dissipation	$P_G (AV)$	0.5	W
Peak Forward Gate Voltage	$V_{GM}$	10	V
Peak Forward Gate Current	$I_{GM}$	2	A
Junction Temperature	$T_j$	-40~125	°C
Storage Temperature Range	$T_{stg}$	-40~125	°C

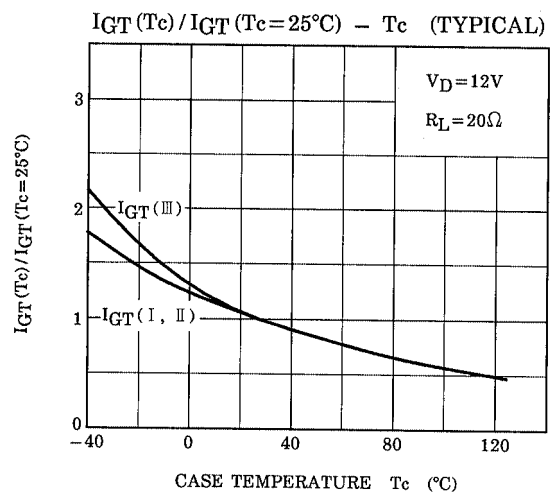
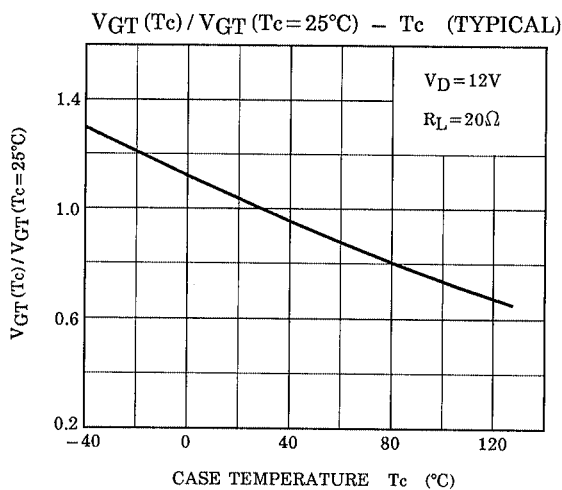
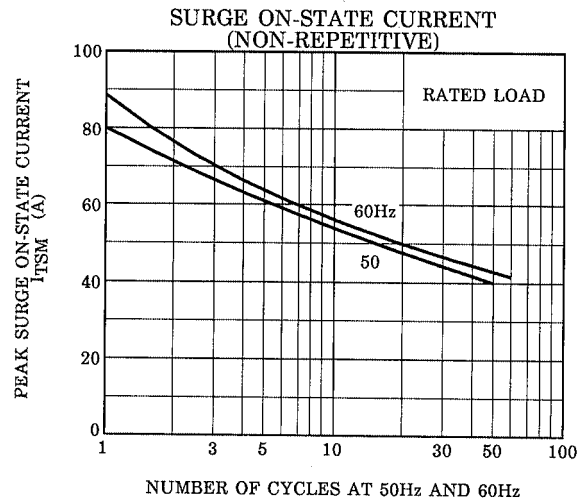
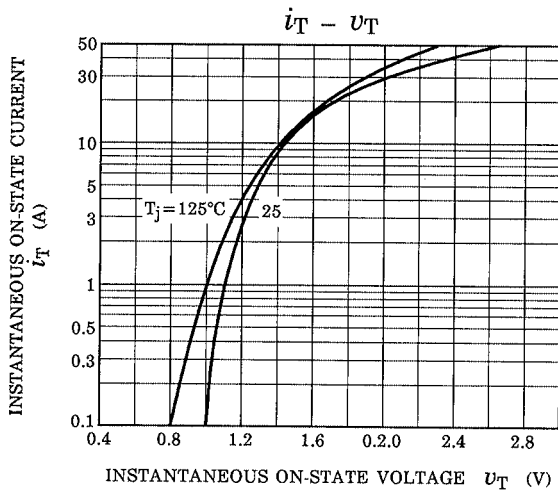
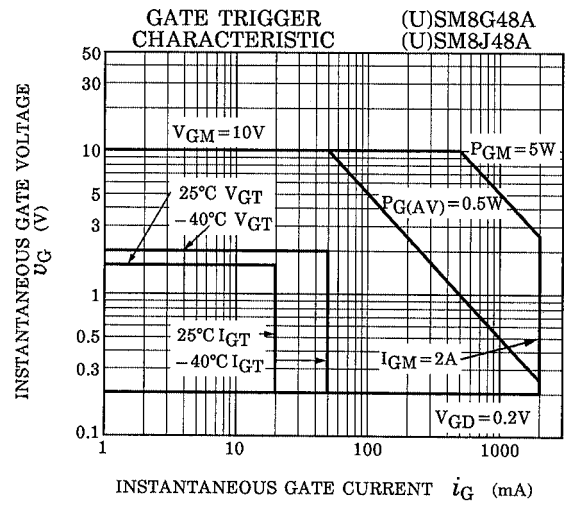
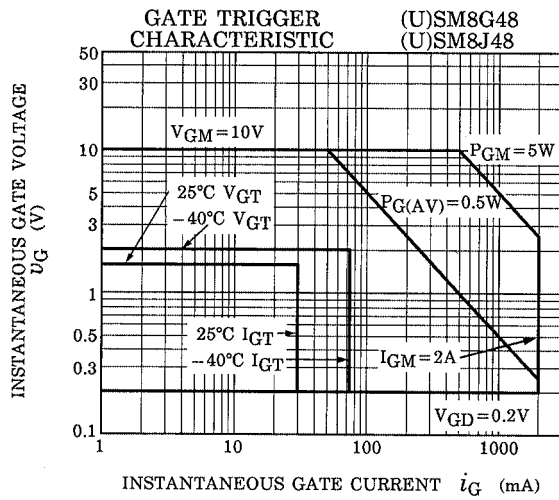
Note 1:  $V_{DRM} = 0.5 \times \text{Rated}$   
 $I_{TM} \leq 12A$   
 $t_{gw} \geq 10\mu s$   
 $t_{gr} \leq 250ns$   
 $i_{gp} = I_{GT} \times 2.0$

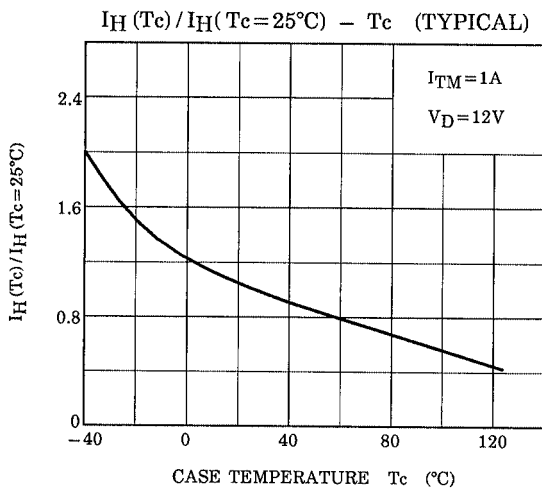
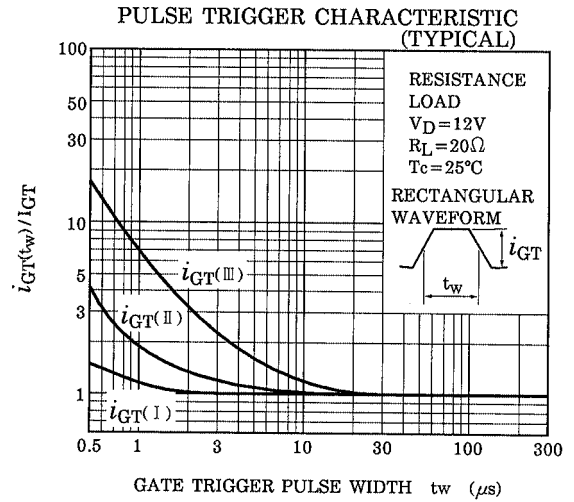
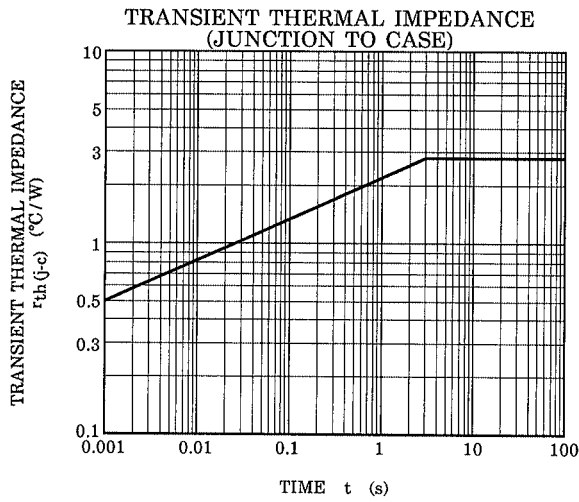
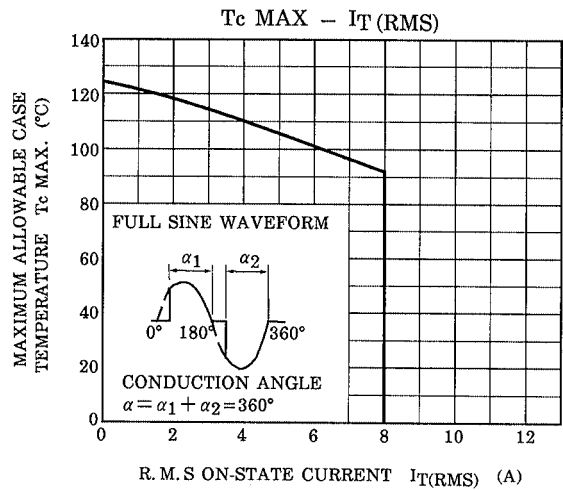
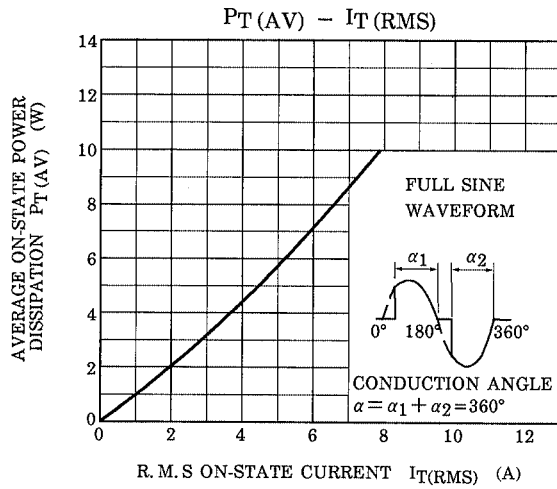
**ELECTRICAL CHARACTERISTICS (Ta = 25°C)**

CHARACTERISTIC		SYMBOL	TEST CONDITION		MIN	TYP.	MAX	UNIT	
Repetitive Peak Off-State Current		I <sub>DRM</sub>	V <sub>DRM</sub> = Rated		—	—	20	μA	
Gate Trigger Voltage		I	V <sub>GT</sub>	V <sub>D</sub> = 12V R <sub>L</sub> = 20Ω	T2 (+), Gate (+)	—	—	1.5	V
		II			T2 (+), Gate (–)	—	—	1.5	
		III			T2 (–), Gate (–)	—	—	1.5	
		IV			T2 (–), Gate (+)	—	—	—	
Gate Trigger Current	(U)SM8G48 (U)SM8J48	I	I <sub>GT</sub>	V <sub>D</sub> = 12V R <sub>L</sub> = 20Ω	T2 (+), Gate (+)	—	—	30	mA
		II			T2 (+), Gate (–)	—	—	30	
		III			T2 (–), Gate (–)	—	—	30	
		IV			T2 (–), Gate (+)	—	—	—	
	(U)SM8G48A (U)SM8J48A	I			T2 (+), Gate (+)	—	—	20	
		II			T2 (+), Gate (–)	—	—	20	
		III			T2 (–), Gate (–)	—	—	20	
		IV			T2 (–), Gate (+)	—	—	—	
Peak On-State Voltage		V <sub>TM</sub>	I <sub>TM</sub> = 12A		—	—	1.5	V	
Gate Non-Trigger Voltage		V <sub>GD</sub>	V <sub>D</sub> = Rated, T <sub>c</sub> = 125°C		0.2	—	—	V	
Holding Current		I <sub>H</sub>	V <sub>D</sub> = 12V, I <sub>TM</sub> = 1A		—	—	50	mA	
Thermal Resistance		R <sub>th (j-c)</sub>	Junction to Case, AC		—	—	2.8	°C / W	
Critical Rate of Rise of Off-State Voltage	(U)SM8G48 (U)SM8J48	dv / dt	V <sub>DRM</sub> = Rated, T <sub>j</sub> = 125°C Exponential Rise	—	300	—	V / μs		
	(U)SM8G48A (U)SM8J48A			—	200	—			
Critical Rate of Rise of Off-State Voltage at Commutation	(U)SM8G48 (U)SM8J48	(dv / dt) c	V <sub>DRM</sub> = 400V, T <sub>j</sub> = 125°C (di / dt) c = –4.5A / ms	10	—	—	V / μs		
	(U)SM8G48A (U)SM8J48A			4	—	—			

**MARKING**


NUMBER	SYMBOL		MARK
* 1	TYPE	SM8G48, SM8G48A, USM8G48, USM8G48A	M8G48
		SM8J48, SM8J48A, USM8J48, USM8J48A	M8J48
* 2	SM8G48A, SM8J48A, USM8G48A, USM8J48A		A
* 3	Lot Number  Month (Starting from Alphabet A) Year (Last Decimal Digit of the Current Year)		Example 8A : January 1998 8B : February 1998 8L : December 1998





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